



STIC Search Report

EIC 2800

STIC Database Tracking Number 124949

TO: Emily Chan
Location: JEF-6A65
Art Unit: 2829
June 25, 2004
Case Serial Number: 10/014,369

From: Jeff Harrison
Location: STIC-EIC2800
JEF-4B68
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Search Notes

Examiner Chan,

Re: Panel inspection apparatus
Mechanism pivots a test electrode and presses against panel electrode(s)

Attached are chronologically-ordered and edited search results from the patent and nonpatent literature.

I did a subject search and a backward/forward-citation search based on relevant patent numbers and IPCs.

Based on this, if you have questions or would like a refocused search, please contact me.

Thanks,
Jeff Harrison
Team Leader, STIC-EIC2800
JEF-4B68, 571-272-2511